S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/919,873	NAMIKI, HIDEO
Examiner	Art Unit
Kevin Mew	2616

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	518	11/20/2007	КМ
Updated	Updated	_	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
(See Se	rarch	11/20/2007	КМ	
History	rintout)			
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
370/230, 230.1,231,232, 386 370/394, 428, 429, 503, 516, 517 (Text search only) Updated search	11/20/2007	КМ